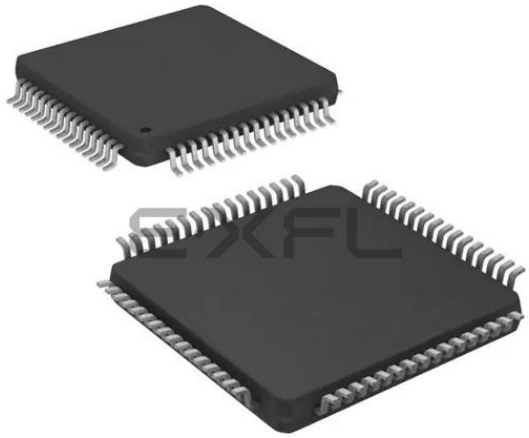

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What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "Embedded - Microcontrollers"

Details	
Product Status	Active
Core Processor	AVR
Core Size	8-Bit
Speed	16MHz
Connectivity	EBI/EMI, I²C, SPI, UART/USART, USB OTG
Peripherals	Brown-out Detect/Reset, POR, PWM, WDT
Number of I/O	48
Program Memory Size	64KB (64K x 8)
Program Memory Type	FLASH
EEPROM Size	2K x 8
RAM Size	4K x 8
Voltage - Supply (Vcc/Vdd)	2.7V ~ 5.5V
Data Converters	A/D 8x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	64-TQFP
Supplier Device Package	64-TQFP (14x14)
Purchase URL	https://www.e-xfl.com/product-detail/microchip-technology/at90usb647-aur

  - Real time counter with separate oscillator
  - Four 8-bit PWM channels
  - Six PWM channels with programmable resolution from 2 to 16 bits
  - Output compare modulator
  - 8-channels, 10-bit ADC
  - Programmable serial USART
  - Master/slave SPI serial interface
  - Byte oriented 2-wire serial interface
  - Programmable watchdog timer with separate on-chip oscillator
  - On-chip analog comparator
  - Interrupt and wake-up on pin change
- Special microcontroller features
  - Power-on reset and programmable brown-out detection
  - Internal calibrated oscillator
  - External and internal interrupt sources
  - Six sleep modes: Idle, ADC Noise Reduction, Power-save, Power-down, Standby, and Extended Standby
- I/O and packages
  - 48 programmable I/O lines
  - 64-lead TQFP and 64-lead QFN
- Operating voltages
  - 2.7 - 5.5V
- Operating temperature
  - Industrial (-40°C to +85°C)
- Maximum frequency
  - 8MHz at 2.7V - industrial range
  - 16MHz at 4.5V - industrial range

1. Pin configurations

Figure 1-1. Pinout Atmel AT90USB64/128-TQFP.

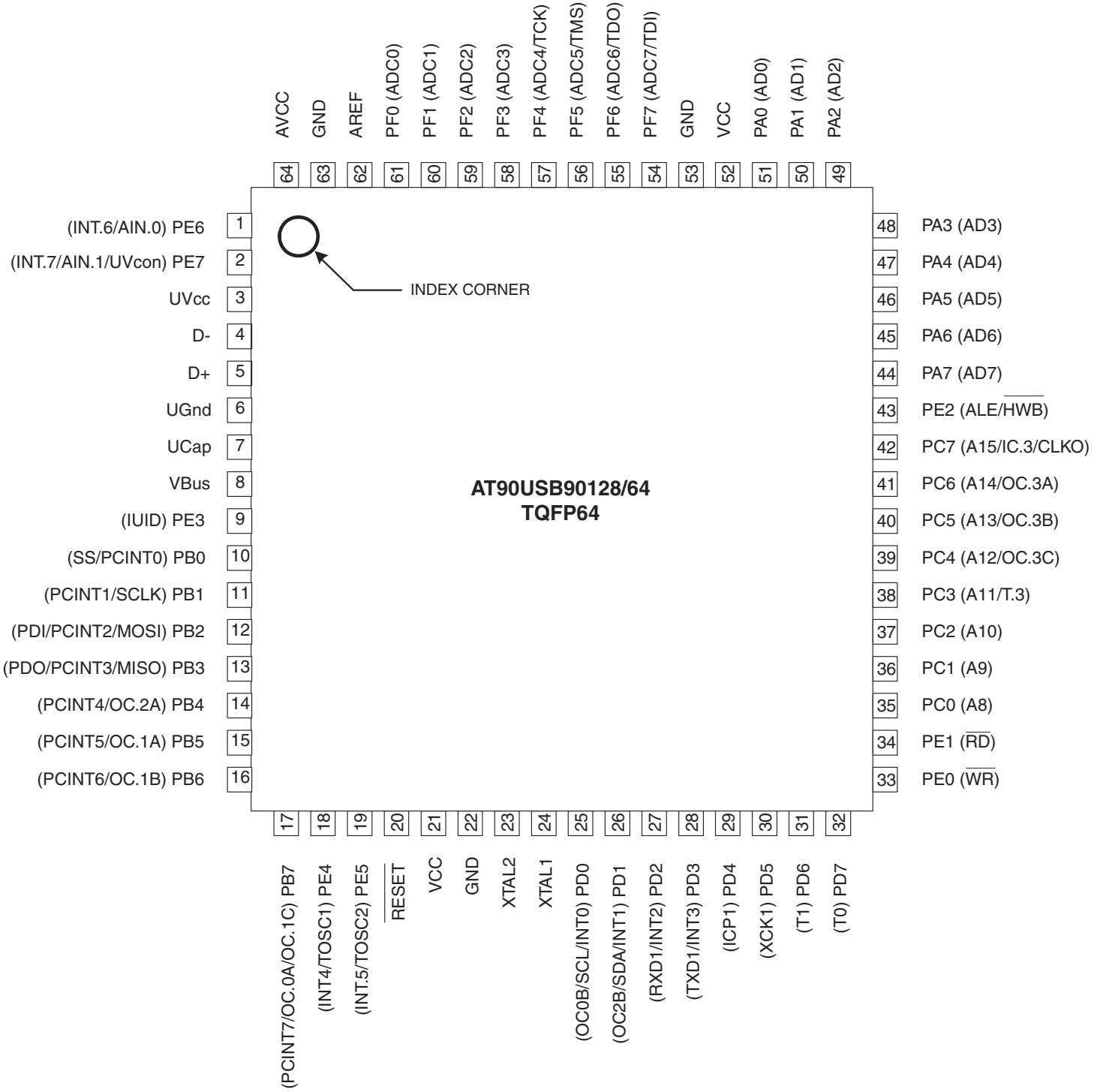
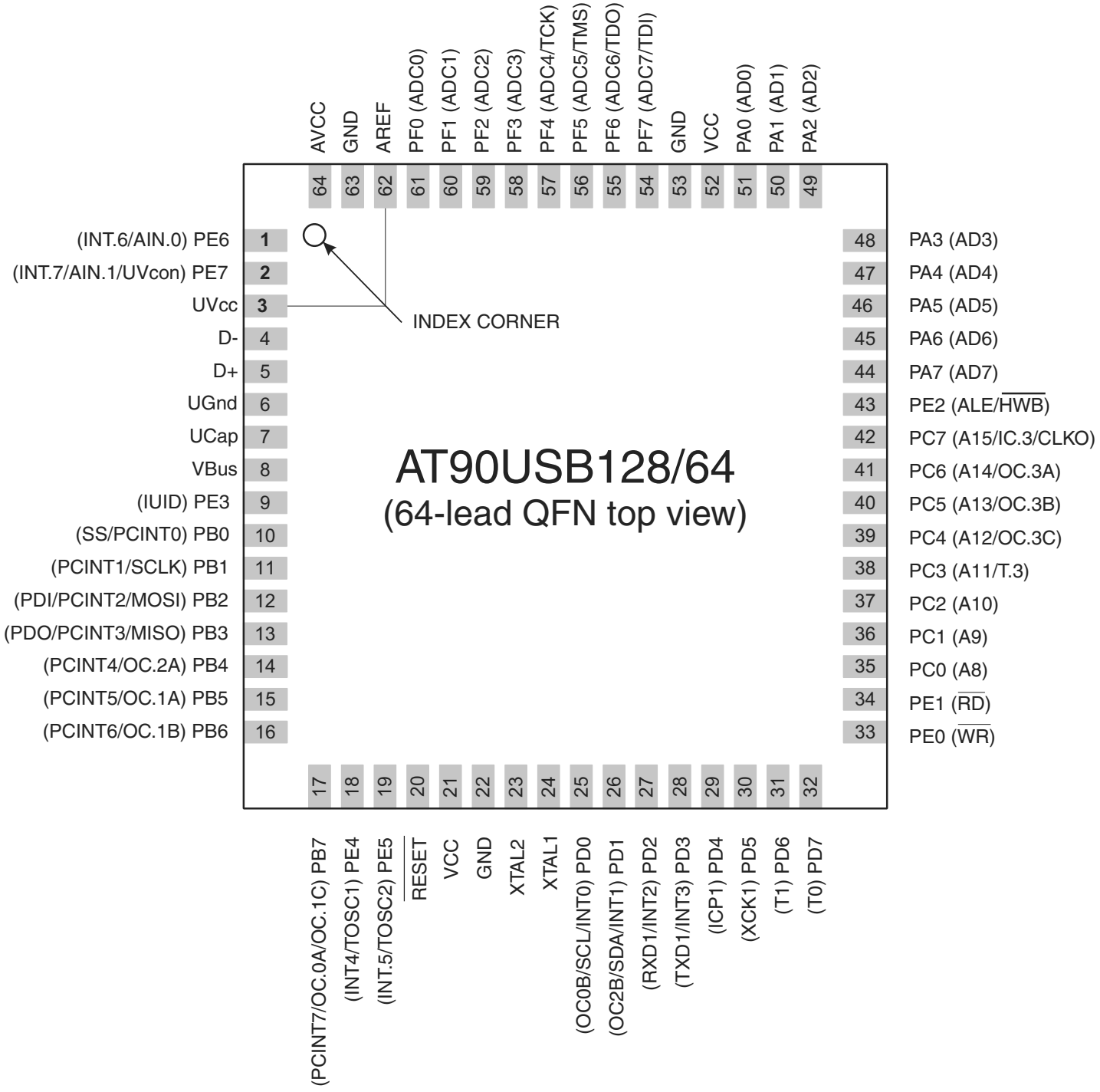


Figure 1-2. Pinout Atmel AT90USB64/128-QFN.



Note: The large center pad underneath the MLF packages is made of metal and internally connected to GND. It should be soldered or glued to the board to ensure good mechanical stability. If the center pad is left unconnected, the package might loosen from the board.

architecture is more code efficient while achieving throughputs up to ten times faster than conventional CISC microcontrollers.

The Atmel AT90USB64/128 provides the following features: 64/128Kbytes of In-System Programmable Flash with Read-While-Write capabilities, 2K/4Kbytes EEPROM, 4K/8K bytes SRAM, 48 general purpose I/O lines, 32 general purpose working registers, Real Time Counter (RTC), four flexible Timer/Counters with compare modes and PWM, one USART, a byte oriented 2-wire Serial Interface, a 8-channels, 10-bit ADC with optional differential input stage with programmable gain, programmable Watchdog Timer with Internal Oscillator, an SPI serial port, IEEE std. 1149.1 compliant JTAG test interface, also used for accessing the On-chip Debug system and programming and six software selectable power saving modes. The Idle mode stops the CPU while allowing the SRAM, Timer/Counters, SPI port, and interrupt system to continue functioning. The Power-down mode saves the register contents but freezes the Oscillator, disabling all other chip functions until the next interrupt or Hardware Reset. In Power-save mode, the asynchronous timer continues to run, allowing the user to maintain a timer base while the rest of the device is sleeping. The ADC Noise Reduction mode stops the CPU and all I/O modules except Asynchronous Timer and ADC, to minimize switching noise during ADC conversions. In Standby mode, the Crystal/Resonator Oscillator is running while the rest of the device is sleeping. This allows very fast start-up combined with low power consumption. In Extended Standby mode, both the main Oscillator and the Asynchronous Timer continue to run.

The device is manufactured using the Atmel high-density nonvolatile memory technology. The On-chip ISP Flash allows the program memory to be reprogrammed in-system through an SPI serial interface, by a conventional nonvolatile memory programmer, or by an On-chip Boot program running on the AVR core. The boot program can use any interface to download the application program in the application Flash memory. Software in the Boot Flash section will continue to run while the Application Flash section is updated, providing true Read-While-Write operation. By combining an 8-bit RISC CPU with In-System Self-Programmable Flash on a monolithic chip, the AT90USB64/128 is a powerful microcontroller that provides a highly flexible and cost effective solution to many embedded control applications.

The AT90USB64/128 AVR is supported with a full suite of program and system development tools including: C compilers, macro assemblers, program debugger/simulators, in-circuit emulators, and evaluation kits.

2.2 Pin descriptions

2.2.1 VCC

Digital supply voltage.

2.2.2 GND

Ground.

2.2.3 AVCC

Analog supply voltage.

2.2.4 Port A (PA7..PA0)

Port A is an 8-bit bidirectional I/O port with internal pull-up resistors (selected for each bit). The Port A output buffers have symmetrical drive characteristics with both high sink and source capability. As inputs, Port A pins that are externally pulled low will source current if the pull-up resistors are activated. The Port A pins are tri-stated when a reset condition becomes active, even if the clock is not running.

Port A also serves the functions of various special features of the Atmel AT90USB64/128 as listed on page 78.

2.2.5 Port B (PB7..PB0)

Port B is an 8-bit bidirectional I/O port with internal pull-up resistors (selected for each bit). The Port B output buffers have symmetrical drive characteristics with both high sink and source capability. As inputs, Port B pins that are externally pulled low will source current if the pull-up resistors are activated. The Port B pins are tri-stated when a reset condition becomes active, even if the clock is not running.

Port B has better driving capabilities than the other ports.

Port B also serves the functions of various special features of the AT90USB64/128 as listed on page 79.

2.2.6 Port C (PC7..PC0)

Port C is an 8-bit bidirectional I/O port with internal pull-up resistors (selected for each bit). The Port C output buffers have symmetrical drive characteristics with both high sink and source capability. As inputs, Port C pins that are externally pulled low will source current if the pull-up resistors are activated. The Port C pins are tri-stated when a reset condition becomes active, even if the clock is not running.

Port C also serves the functions of special features of the AT90USB64/128 as listed on page 82.

2.2.7 Port D (PD7..PD0)

Port D is an 8-bit bi-directional I/O port with internal pull-up resistors (selected for each bit). The Port D output buffers have symmetrical drive characteristics with both high sink and source capability. As inputs, Port D pins that are externally pulled low will source current if the pull-up resistors are activated. The Port D pins are tri-stated when a reset condition becomes active, even if the clock is not running.

Port D also serves the functions of various special features of the AT90USB64/128 as listed on page 83.

2.2.8 Port E (PE7..PE0)

Port E is an 8-bit bidirectional I/O port with internal pull-up resistors (selected for each bit). The Port E output buffers have symmetrical drive characteristics with both high sink and source capability. As inputs, Port E pins that are externally pulled low will source current if the pull-up resistors are activated. The Port E pins are tri-stated when a reset condition becomes active, even if the clock is not running.

Port E also serves the functions of various special features of the AT90USB64/128 as listed on page 86.

2.2.9 Port F (PF7..PF0)

Port F serves as analog inputs to the A/D Converter.

Port F also serves as an 8-bit bidirectional I/O port, if the A/D Converter is not used. Port pins can provide internal pull-up resistors (selected for each bit). The Port F output buffers have symmetrical drive characteristics with both high sink and source capability. As inputs, Port F pins that are externally pulled low will source current if the pull-up resistors are activated. The Port F pins are tri-stated when a reset condition becomes active, even if the clock is not running. If the JTAG interface is enabled, the pull-up resistors on pins PF7(TDI), PF5(TMS), and PF4(TCK) will be activated even if a reset occurs.

Port F also serves the functions of the JTAG interface.

2.2.10 D-

USB Full speed / Low Speed Negative Data Upstream Port. Should be connected to the USB D- connector pin with a serial 22Ω resistor.

2.2.11 D+

USB Full speed / Low Speed Positive Data Upstream Port. Should be connected to the USB D+ connector pin with a serial 22Ω resistor.

2.2.12 UGND

USB Pads Ground.

2.2.13 UVCC

USB Pads Internal Regulator Input supply voltage.

2.2.14 UCAP

USB Pads Internal Regulator Output supply voltage. Should be connected to an external capacitor (1µF).

2.2.15 VBUS

USB VBUS monitor and OTG negociations.

2.2.16 $\overline{\text{RESET}}$

Reset input. A low level on this pin for longer than the minimum pulse length will generate a reset, even if the clock is not running. The minimum pulse length is given in Table 9-1 on page 58. Shorter pulses are not guaranteed to generate a reset.

2.2.17 XTAL1

Input to the inverting Oscillator amplifier and input to the internal clock operating circuit.

5. Register summary

Address	Name	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	Page
(0xFF)	Reserved	-	-	-	-	-	-	-	-	
(0xFE)	Reserved	-	-	-	-	-	-	-	-	
(0xFD)	Reserved	-	-	-	-	-	-	-	-	
(0xFC)	Reserved	-	-	-	-	-	-	-	-	
(0xFB)	Reserved	-	-	-	-	-	-	-	-	
(0xFA)	Reserved	-	-	-	-	-	-	-	-	
(0xF9)	OTGTCON		PAGE					VALUE		
(0xF8)	UPINT	PINT7:0								
(0xF7)	UPBCHX	-	-	-	-	-	PBYCT10:8			
(0xF6)	UPBCLX	PBYCT7:0								
(0xF5)	UPERRX	-	COUNTER1:0		CRC16	TIMEOUT	PID	DATAPID	DATATGL	
(0xF4)	UEINT	EPINT6:0								
(0xF3)	UEBCHX	-	-	-	-	-	BYCT10:8			
(0xF2)	UEBCLX	BYCT7:0								
(0xF1)	UEDATX	DAT7:0								
(0xF0)	UEIENX	FLERRE	NAKINE	-	NAKOUTE	RXSTPE	RXOUTE	STALLEDE	TXINE	
(0xEF)	UESTA1X	-	-	-	-	-	CTRLDIR	CURRBK1:0		
(0xEE)	UESTA0X	CFGOK	OVERFI	UNDERFI	-	DTSEQ1:0		NBUSYBK1:0		
(0xED)	UECFG1X		EPSIZE2:0			EPBK1:0		ALLOC		
(0xEC)	UECFG0X	EPTYPE1:0					-	-	EPDIR	
(0xEB)	UECONX			STALLRQ	STALLRQC	RSTDT			EPEN	
(0xEA)	UERST	EPRST6:0								
(0xE9)	UENUM						EPNUM2:0			
(0xE8)	UEINTX	FIFOCON	NAKINI	RWAL	NAKOUTI	RXSTPI	RXOUTI	STALLEDI	TXINI	
(0xE7)	Reserved			-	-	-	-			
(0xE6)	UDMFN				FNCERR					
(0xE5)	UDFNUMH						FNUM10:8			
(0xE4)	UDFNUML	FNUM7:0								
(0xE3)	UDADDR	ADDEN	UADD6:0							
(0xE2)	UDIEN		UPRSME	EORSME	WAKEUPE	EORSTE	SOFE		SUSPE	
(0xE1)	UDINT		UPRSMI	EORSMI	WAKEUPI	EORSTI	SOFI		SUSPI	
(0xE0)	UDCON						LSM	RMWKUP	DETACH	
(0xDF)	OTGINT			STOI	HNPERRI	ROLEEXI	BCERRI	VBERRI	SRPI	
(0xDE)	OTGIEN			STOE	HNPERRE	ROLEEXE	BCERRE	VBERRE	SRPE	
(0xDD)	OTGCON			HNPREQ	SRPREQ	SRPSEL	VBUSHWC	VBUSREQ	VBUSRQC	
(0xDC)	Reserved									
(0xDB)	Reserved									
(0xDA)	USBINT							IDTI	VBUSTI	
(0xD9)	USBSTA					SPEED		ID	VBUS	
(0xD8)	USBCON	USBE	HOST	FRZCLK	OTGPADE			IDTE	VBUSTE	
(0xD7)	UHWCON	UIMOD	UIDE		UVCONE				UVREGE	
(0xD6)	Reserved									
(0xD5)	Reserved									
(0xD4)	Reserved									
(0xD3)	Reserved									
(0xD2)	Reserved	-	-	-	-	-	-	-	-	
(0xD1)	Reserved	-	-	-	-	-	-	-	-	
(0xD0)	Reserved	-	-	-	-	-	-	-	-	
(0xCF)	Reserved	-	-	-	-	-	-	-	-	
(0xCE)	UDR1	USART1 I/O Data Register								
(0xCD)	UBRR1H	-	-	-	-	USART1 Baud Rate Register High Byte				
(0xCC)	UBRR1L	USART1 Baud Rate Register Low Byte								
(0xCB)	Reserved	-	-	-	-	-	-	-	-	
(0xCA)	UCSR1C	UMSEL11	UMSEL10	UPM11	UPM10	USBS1	UCSZ11	UCSZ10	UCPOL1	
(0xC9)	UCSR1B	RXCIE1	TXCIE1	UDRIE1	RXEN1	TXEN1	UCSZ12	RXB81	TXB81	
(0xC8)	UCSR1A	RXC1	TXC1	UDRE1	FE1	DOR1	PE1	U2X1	MPCM1	
(0xC7)	Reserved	-	-	-	-	-	-	-	-	
(0xC6)	Reserved	-	-	-	-	-	-	-	-	
(0xC5)	Reserved	-	-	-	-	-	-	-	-	
(0xC4)	Reserved	-	-	-	-	-	-	-	-	
(0xC3)	Reserved	-	-	-	-	-	-	-	-	
(0xC2)	Reserved	-	-	-	-	-	-	-	-	
(0xC1)	Reserved	-	-	-	-	-	-	-	-	
(0xC0)	Reserved	-	-	-	-	-	-	-	-	
(0xBF)	Reserved	-	-	-	-	-	-	-	-	

Address	Name	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	Page
(0xBE)	Reserved	-	-	-	-	-	-	-	-	
(0xBD)	TWAMR	TWAM6	TWAM5	TWAM4	TWAM3	TWAM2	TWAM1	TWAM0	-	
(0xBC)	TWCR	TWINT	TWEA	TWSTA	TWSTO	TWWC	TWEN	-	TWIE	
(0xBB)	TWDR	2-wire Serial Interface Data Register								
(0xBA)	TWAR	TWA6	TWA5	TWA4	TWA3	TWA2	TWA1	TWA0	TWGCE	
(0xB9)	TWSR	TWS7	TWS6	TWS5	TWS4	TWS3	-	TWPS1	TWPS0	
(0xB8)	TWBR	2-wire Serial Interface Bit Rate Register								
(0xB7)	Reserved	-	-	-	-	-	-	-	-	
(0xB6)	ASSR	-	EXCLK	AS2	TCN2UB	OCR2AUB	OCR2BUB	TCR2AUB	TCR2BUB	
(0xB5)	Reserved	-	-	-	-	-	-	-	-	
(0xB4)	OCR2B	Timer/Counter2 Output Compare Register B								
(0xB3)	OCR2A	Timer/Counter2 Output Compare Register A								
(0xB2)	TCNT2	Timer/Counter2 (8 Bit)								
(0xB1)	TCCR2B	FOC2A	FOC2B	-	-	WGM22	CS22	CS21	CS20	
(0xB0)	TCCR2A	COM2A1	COM2A0	COM2B1	COM2B0	-	-	WGM21	WGM20	
(0xAF)	UPDATX	PDAT7:0								
(0xAE)	UPIENX	FLERRE	NAKEDE	-	PERRE	TXSTPE	TXOUTE	RXSTALLE	RXINE	
(0xAD)	UPCFG2X	INTFRQ7:0								
(0xAC)	UPSTAX	CFGOK	OVERFI	UNDERFI		DTSEQ1:0		NBUSYBK1:0		
(0xAB)	UPCFG1X		PSIZE2:0			PBK1:0		ALLOC		
(0xAA)	UPCFG0X	PTYPE1:0		PTOKEN1:0		PEPNUM3:0				
(0xA9)	UPCONX		PFREEZE	INMODE		RSTDT			PEN	
(0xA8)	UPRST		PRST6:0							
(0xA7)	UPNUM						PNUM2:0			
(0xA6)	UPINTX	FIFOCON	NAKEDI	RWAL	PERRI	TXSTPI	TXOUTI	RXSTALLI	RXINI	
(0xA5)	UPINRQX	INRQ7:0								
(0xA4)	UHFLEN	FLEN7:0								
(0xA3)	UHFNUMH						FNUM10:8			
(0xA2)	UHFNUML	FNUM7:0								
(0xA1)	UHADDR		HADD6:0							
(0xA0)	UHIEN		HWUPE	HSOFE	RXRSME	RSMEDE	RSTE	DDISCE	DCONNE	
(0x9F)	UHINT		HWUPI	HSOFI	RXRSMI	RSMEDI	RSTI	DDISCI	DCONNI	
(0x9E)	UHCON						RESUME	RESET	SOFEN	
(0x9D)	OCR3CH	Timer/Counter3 - Output Compare Register C High Byte								
(0x9C)	OCR3CL	Timer/Counter3 - Output Compare Register C Low Byte								
(0x9B)	OCR3BH	Timer/Counter3 - Output Compare Register B High Byte								
(0x9A)	OCR3BL	Timer/Counter3 - Output Compare Register B Low Byte								
(0x99)	OCR3AH	Timer/Counter3 - Output Compare Register A High Byte								
(0x98)	OCR3AL	Timer/Counter3 - Output Compare Register A Low Byte								
(0x97)	ICR3H	Timer/Counter3 - Input Capture Register High Byte								
(0x96)	ICR3L	Timer/Counter3 - Input Capture Register Low Byte								
(0x95)	TCNT3H	Timer/Counter3 - Counter Register High Byte								
(0x94)	TCNT3L	Timer/Counter3 - Counter Register Low Byte								
(0x93)	Reserved	-	-	-	-	-	-	-	-	
(0x92)	TCCR3C	FOC3A	FOC3B	FOC3C	-	-	-	-	-	
(0x91)	TCCR3B	ICNC3	ICES3	-	WGM33	WGM32	CS32	CS31	CS30	
(0x90)	TCCR3A	COM3A1	COM3A0	COM3B1	COM3B0	COM3C1	COM3C0	WGM31	WGM30	
(0x8F)	Reserved	-	-	-	-	-	-	-	-	
(0x8E)	Reserved	-	-	-	-	-	-	-	-	
(0x8D)	OCR1CH	Timer/Counter1 - Output Compare Register C High Byte								
(0x8C)	OCR1CL	Timer/Counter1 - Output Compare Register C Low Byte								
(0x8B)	OCR1BH	Timer/Counter1 - Output Compare Register B High Byte								
(0x8A)	OCR1BL	Timer/Counter1 - Output Compare Register B Low Byte								
(0x89)	OCR1AH	Timer/Counter1 - Output Compare Register A High Byte								
(0x88)	OCR1AL	Timer/Counter1 - Output Compare Register A Low Byte								
(0x87)	ICR1H	Timer/Counter1 - Input Capture Register High Byte								
(0x86)	ICR1L	Timer/Counter1 - Input Capture Register Low Byte								
(0x85)	TCNT1H	Timer/Counter1 - Counter Register High Byte								
(0x84)	TCNT1L	Timer/Counter1 - Counter Register Low Byte								
(0x83)	Reserved	-	-	-	-	-	-	-	-	
(0x82)	TCCR1C	FOC1A	FOC1B	FOC1C	-	-	-	-	-	
(0x81)	TCCR1B	ICNC1	ICES1	-	WGM13	WGM12	CS12	CS11	CS10	
(0x80)	TCCR1A	COM1A1	COM1A0	COM1B1	COM1B0	COM1C1	COM1C0	WGM11	WGM10	
(0x7F)	DIDR1	-	-	-	-	-	-	AIN1D	AIN0D	
(0x7E)	DIDR0	ADC7D	ADC6D	ADC5D	ADC4D	ADC3D	ADC2D	ADC1D	ADC0D	
(0x7D)	-	-	-	-	-	-	-	-	-	

Mnemonics	Operands	Description	Operation	Flags	#Clocks
SPM		Store Program Memory	(Z) ← R1:R0	None	-
IN	Rd, P	In Port	Rd ← P	None	1
OUT	P, Rr	Out Port	P ← Rr	None	1
PUSH	Rr	Push Register on Stack	STACK ← Rr	None	2
POP	Rd	Pop Register from Stack	Rd ← STACK	None	2
MCU CONTROL INSTRUCTIONS					
NOP		No Operation		None	1
SLEEP		Sleep	(see specific descr. for Sleep function)	None	1
WDR		Watchdog Reset	(see specific descr. for WDR/timer)	None	1
BREAK		Break	For On-chip Debug Only	None	N/A

NOTES: QFN STANDARD NOTES

1. DIMENSIONING & TOLERANCING CONFORM TO ASME Y14.5M. – 1994.

2. DIMENSION b APPLIES TO METALLIZED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30 mm FROM TERMINAL TIP. IF THE TERMINAL HAS THE OPTIONAL RADIUS ON THE OTHER END OF THE TERMINAL, THE DIMENSION b SHOULD NOT BE MEASURED IN THAT RADIUS AREA.

3. MAX. PACKAGE WARPAGE IS 0.05mm.

4. MAXIMUM ALLOWABLE BURRS IS 0.076 mm IN ALL DIRECTIONS.

5. PIN #1 ID ON TOP WILL BE LASER MARKED.

6. THIS DRAWING CONFORMES TO JEDEC REGISTERED OUTLINE MO–220.

7. A MAXIMUM 0.15mm PULL BACK (L1) MAY BE PRESENT.
L MINUS L1 TO BE EQUAL TO OR GREATER THAN 0.30 mm

8. THE TERMINAL #1 IDENTIFIER ARE OPTIONAL BUT MUST BE LOCATED WITHIN THE ZONE INDICATED. THE TERMINAL #1 IDENTIFIER BE EITHER A MOLD OR MARKED FEATURE

9. Errata

9.1 Atmel AT90USB1287/6 errata

9.1.1 AT90USB1287/6 errata history

Silicon Release	90USB1286-16MU	90USB1287-16AU	90USB1287-16MU
First Release	Date Code up to 0648	Date Code up to 0714 and lots 0735 6H2726 (1)	Date Code up to 0701
Second Release	Date Code from 0709 to 0801 except lots 0801 7H5103 (1)	from Date Code 0722 to 0806 except lots 0735 6H2726 (1)	Date Code from 0714 to 0810 except lots 0748 7H5103 (1)
Third Release	Lots 0801 7H5103 (1) and Date Code from 0814	Date Code from 0814	Lots 0748 7H5103 (1) and Date Code from 0814
Fourth Release	TBD	TBD	TBD

Notes: 1. A blank or any alphanumeric string.

9.1.2 AT90USB1287/6 first release

- Incorrect CPU behavior for VBUSTI and IDTI interrupts routines
- USB Eye Diagram violation in low-speed mode
- Transient perturbation in USB suspend mode generates over consumption
- VBUS Session valid threshold voltage
- USB signal rate
- VBUS residual level
- Spike on TWI pins when TWI is enabled
- High current consumption in sleep mode
- Async timer interrupt wake up from sleep generate multiple interrupts

9. Incorrect CPU behavior for VBUSTI and IDTI interrupts routines

The CPU core may incorrectly execute the interrupt vector related to the VBUSTI and IDTI interrupt flags.

Problem fix/workaround

Do not enable these interrupts, firmware must process these USB events by polling VBUSTI and IDTI flags.

8. USB Eye Diagram violation in low-speed mode

The low to high transition of D- violates the USB eye diagram specification when transmitting with low-speed signaling.

Problem fix/workaround

None.

7. Transient perturbation in USB suspend mode generates overconsumption

In device mode and when the USB is suspended, transient perturbation received on the USB lines generates a wake up state. However the idle state following the perturbation does

not set the SUSPI bit anymore. The internal USB engine remains in suspend mode but the USB differential receiver is still enabled and generates a typical 300µA extra-power consumption. Detection of the suspend state after the transient perturbation should be performed by software (instead of reading the SUSPI bit).

Problem fix/workaround

USB waiver allows bus powered devices to consume up to 2.5mA in suspend state.

6. VBUS session valid threshold voltage

The VSession valid threshold voltage is internally connected to VBus_Valid (4.4V approx.). That causes the device to attach to the bus only when Vbus is greater than VBusValid instead of V_Session Valid. Thus if VBUS is lower than 4.4V, the device is detached.

Problem fix/workaround

According to the USB power drop budget, this may require connecting the device toa root hub or a self-powered hub.

5. UBS signal rate

The average USB signal rate may sometime be measured out of the USB specifications (12MHz ±30kHz) with short frames. When measured on a long period, the average signal rate value complies with the specifications. This bit rate deviation does not generates communication or functional errors.

Problem fix/workaround

None.

4. VBUS residual level

In USB device and host mode, once a 5V level has been detected to the VBUS pad, a residual level (about 3V) can be measured on the VBUS pin.

Problem fix/workaround

None.

3. Spike on TWI pins when TWI is enabled

100ns negative spike occurs on SDA and SCL pins when TWI is enabled.

Problem fix/workaround

No known workaround, enable Atmel AT90USB64/128 TWI first versus the others nodes of the TWI network.

2. High current consumption in sleep mode

If a pending interrupt cannot wake the part up from the selected mode, the current consumption will increase during sleep when executing the SLEEP instruction directly after a SEI instruction.

Problem fix/workaround

Before entering sleep, interrupts not used to wake up the part from the sleep mode should be disabled.

1. **Asynchronous timer interrupt wake up from sleep generates multiple interrupts**
   If the CPU core is in sleep and wakes-up from an asynchronous timer interrupt and then go back in sleep again it may wake up multiple times.

   Problem fix/workaround
   A software workaround is to wait with performing the sleep instruction until TCNT2>OCR2+1.

9.1.3 Atmel AT90USB1287/6 second release

- Incorrect CPU behavior for VBUSTI and IDTI interrupts routines
- USB Eye Diagram violation in low-speed mode
- Transient perturbation in USB suspend mode generates over consumption
- VBUS Session valid threshold voltage
- Spike on TWI pins when TWI is enabled
- High current consumption in sleep mode
- Async timer interrupt wake up from sleep generate multiple interrupts

7. Incorrect CPU behavior for VBUSTI and IDTI interrupts routines

The CPU core may incorrectly execute the interrupt vector related to the VBUSTI and IDTI interrupt flags.

Problem fix/workaround

Do not enable these interrupts, firmware must process these USB events by polling VBUSTI and IDTI flags.

6. USB Eye Diagram violation in low-speed mode

The low to high transition of D- violates the USB eye diagram specification when transmitting with low-speed signaling.

Problem fix/workaround

None.

5. Transient perturbation in USB suspend mode generates overconsumption

In device mode and when the USB is suspended, transient perturbation received on the USB lines generates a wake up state. However the idle state following the perturbation does not set the SUSPI bit anymore. The internal USB engine remains in suspend mode but the USB differential receiver is still enabled and generates a typical 300µA extra-power consumption. Detection of the suspend state after the transient perturbation should be performed by software (instead of reading the SUSPI bit).

Problem fix/workaround

USB waiver allows bus powered devices to consume up to 2.5mA in suspend state.

4. VBUS session valid threshold voltage

The VSession valid threshold voltage is internally connected to VBus_Valid (4.4V approx.). That causes the device to attach to the bus only when Vbus is greater than VBusValid instead of V_Session Valid. Thus if VBUS is lower than 4.4V, the device is detached.

Problem fix/workaround

According to the USB power drop budget, this may require connecting the device toa root hub or a self-powered hub.

3. Spike on TWI pins when TWI is enabled

100ns negative spike occurs on SDA and SCL pins when TWI is enabled.

Problem fix/workaround

No known workaround, enable Atmel AT90USB64/128 TWI first versus the others nodes of the TWI network.

2. High current consumption in sleep mode

If a pending interrupt cannot wake the part up from the selected mode, the current consumption will increase during sleep when executing the SLEEP instruction directly after a SEI instruction.

Problem fix/workaround

Before entering sleep, interrupts not used to wake up the part from the sleep mode should be disabled.

1. Asynchronous timer interrupt wake up from sleep generates multiple interrupts

If the CPU core is in sleep and wakes-up from an asynchronous timer interrupt and then go back in sleep again it may wake up multiple times.

Problem fix/workaround

A software workaround is to wait with performing the sleep instruction until TCNT2>OCR2+1.

9.1.4 Atmel AT90USB1287/6 Third Release

- Incorrect CPU behavior for VBUSTI and IDTI interrupts routines
- Transient perturbation in USB suspend mode generates over consumption
- Spike on TWI pins when TWI is enabled
- High current consumption in sleep mode
- Async timer interrupt wake up from sleep generate multiple interrupts

5. Incorrect CPU behavior for VBUSTI and IDTI interrupts routines

The CPU core may incorrectly execute the interrupt vector related to the VBUSTI and IDTI interrupt flags.

Problem fix/workaround

Do not enable these interrupts, firmware must process these USB events by polling VBUSTI and IDTI flags.

4. Transient perturbation in USB suspend mode generates overconsumption

In device mode and when the USB is suspended, transient perturbation received on the USB lines generates a wake up state. However the idle state following the perturbation does not set the SUSPI bit. The internal USB engine remains in suspend mode but the USB differential receiver is still enabled and generates a typical 300µA extra-power consumption. Detection of the suspend state after the transient perturbation should be performed by software (instead of reading the SUSPI bit).

Problem fix/workaround

USB waiver allows bus powered devices to consume up to 2.5mA in suspend state.

3. Spike on TWI pins when TWI is enabled

100ns negative spike occurs on SDA and SCL pins when TWI is enabled.

Problem fix/workaround

No known workaround, enable AT90USB64/128 TWI first, before the others nodes of the TWI network.

2. High current consumption in sleep mode

If a pending interrupt cannot wake the part up from the selected mode, the current consumption will increase during sleep when executing the SLEEP instruction directly after a SEI instruction.

Problem fix/workaround

Before entering sleep, interrupts not used to wake up the part from sleep mode should be disabled.

1. Asynchronous timer interrupt wake up from sleep generates multiple interrupts

If the CPU core is in sleep mode and wakes-up from an asynchronous timer interrupt and then goes back into sleep mode, it may wake up multiple times.

9.1.5 Atmel AT90USB1287/6 Fourth Release

- Transient perturbation in USB suspend mode generates over consumption
- Spike on TWI pins when TWI is enabled
- High current consumption in sleep mode
- Async timer interrupt wake up from sleep generate multiple interrupts

4. **Transient perturbation in USB suspend mode generates overconsumption**
   In device mode and when the USB is suspended, transient perturbation received on the USB lines generates a wake up state. However the idle state following the perturbation does not set the SUSPI bit. The internal USB engine remains in suspend mode but the USB differential receiver is still enabled and generates a typical 300µA extra-power consumption. Detection of the suspend state after the transient perturbation should be performed by software (instead of reading the SUSPI bit).

   Problem fix/workaround
   USB waiver allows bus powered devices to consume up to 2.5mA in suspend state.

3. **Spike on TWI pins when TWI is enabled**
   100ns negative spike occurs on SDA and SCL pins when TWI is enabled.

   Problem fix/workaround
   No known workaround, enable Atmel AT90USB64/128 TWI first, before the others nodes of the TWI network.

2. **High current consumption in sleep mode**
   If a pending interrupt cannot wake the part up from the selected mode, the current consumption will increase during sleep when executing the SLEEP instruction directly after a SEI instruction.

   Problem fix/workaround
   Before entering sleep, interrupts not used to wake up the part from sleep mode should be disabled.

1. **Asynchronous timer interrupt wake up from sleep generates multiple interrupts**
   If the CPU core is in sleep mode and wakes-up from an asynchronous timer interrupt and then goes back into sleep mode, it may wake up multiple times.

   Problem fix/workaround
   A software workaround is to wait before performing the sleep instruction: until TCNT2>OCR2+1.

9.2 Atmel AT90USB646/7 errata

9.2.1 AT90USB646/7 errata history TBD

Silicon Release	90USB646-16MU	90USB647-16AU	90USB647-16MU
First Release			
Second Release			

Note '*' means a blank or any alphanumeric string.

9.2.2 AT90USB646/7 first release.

- Incorrect interrupt routine execution for VBUSTI, IDTI interrupts flags
- USB Eye Diagram violation in low-speed mode
- Transient perturbation in USB suspend mode generates over consumption
- Spike on TWI pins when TWI is enabled
- High current consumption in sleep mode
- Async timer interrupt wake up from sleep generate multiple interrupts

6. Incorrect CPU behavior for VBUSTI and IDTI interrupts routines

The CPU core may incorrectly execute the interrupt vector related to the VBUSTI and IDTI interrupt flags.

Problem fix/workaround

Do not enable these interrupts, firmware must process these USB events by polling VBUSTI and IDTI flags.

5. USB Eye Diagram violation in low-speed mode

The low to high transition of D- violates the USB eye diagram specification when transmitting with low-speed signaling.

Problem fix/workaround

None.

4. Transient perturbation in USB suspend mode generates overconsumption

In device mode and when the USB is suspended, transient perturbation received on the USB lines generates a wake up state. However the idle state following the perturbation does not set the SUSPI bit anymore. The internal USB engine remains in suspend mode but the USB differential receiver is still enabled and generates a typical 300µA extra-power consumption. Detection of the suspend state after the transient perturbation should be performed by software (instead of reading the SUSPI bit).

Problem fix/workaround

USB waiver allows bus powered devices to consume up to 2.5mA in suspend state.

3. Spike on TWI pins when TWI is enabled

100ns negative spike occurs on SDA and SCL pins when TWI is enabled.

9.2.3 Atmel AT90USB646/7 Second Release.

- USB Eye Diagram violation in low-speed mode
- Transient perturbation in USB suspend mode generates over consumption
- Spike on TWI pins when TWI is enabled
- High current consumption in sleep mode
- Async timer interrupt wake up from sleep generate multiple interrupts

5. USB Eye Diagram violation in low-speed mode

The low to high transition of D- violates the USB eye diagram specification when transmitting with low-speed signaling.

Problem fix/workaround
None.

4. Transient perturbation in USB suspend mode generates overconsumption

In device mode and when the USB is suspended, transient perturbation received on the USB lines generates a wake up state. However the idle state following the perturbation does not set the SUSPI bit anymore. The internal USB engine remains in suspend mode but the USB differential receiver is still enabled and generates a typical 300µA extra-power consumption. Detection of the suspend state after the transient perturbation should be performed by software (instead of reading the SUSPI bit).

Problem fix/workaround
USB waiver allows bus powered devices to consume up to 2.5mA in suspend state.

3. Spike on TWI pins when TWI is enabled

100ns negative spike occurs on SDA and SCL pins when TWI is enabled.

Problem fix/workaround
No known workaround, enable Atmel AT90USB64/128 TWI first versus the others nodes of the TWI network.

2. High current consumption in sleep mode

If a pending interrupt cannot wake the part up from the selected mode, the current consumption will increase during sleep when executing the SLEEP instruction directly after a SEI instruction.

Problem fix/workaround
Before entering sleep, interrupts not used to wake up the part from the sleep mode should be disabled.

1. Asynchronous timer interrupt wake up from sleep generates multiple interrupts

If the CPU core is in sleep and wakes-up from an asynchronous timer interrupt and then go back in sleep mode again it may wake up several times.

Problem fix/workaround
A software workaround is to wait with performing the sleep instruction until TCNT2>OCR2+1.

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